# 2SK2568

# Silicon N-Channel MOS FET

# **HITACHI**

Preliminary

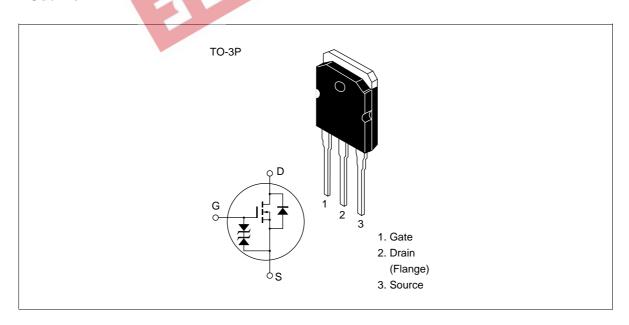
### **Application**

High speed power switching

#### **Features**

- Low on-resistance
- High speed switching
- Low drive current
- T. Com. cn Suitable for switching regulator and DC-DC converter

#### **Outline**





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### **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit					
Drain to source voltage	V <sub>DSS</sub>	500	V					
Gate to source voltage	$V_{GSS}$	±30	V					
Drain current	I <sub>D</sub> *2	12	А					
Drain peak current	To(pulse) *1	48	А					
Body to drain diode reverse drain current	I <sub>DR</sub> *2	12	А					
Channel dissipation	Pch*2	100	W					
Channel temperature	Tch	150	°C					
Storage temperature	Tstg	-55 to +150	°C					
Notes: 1. PW ≤ 10 μs, duty cycle ≤ 1 % 2. Value at Tc = 25°C								

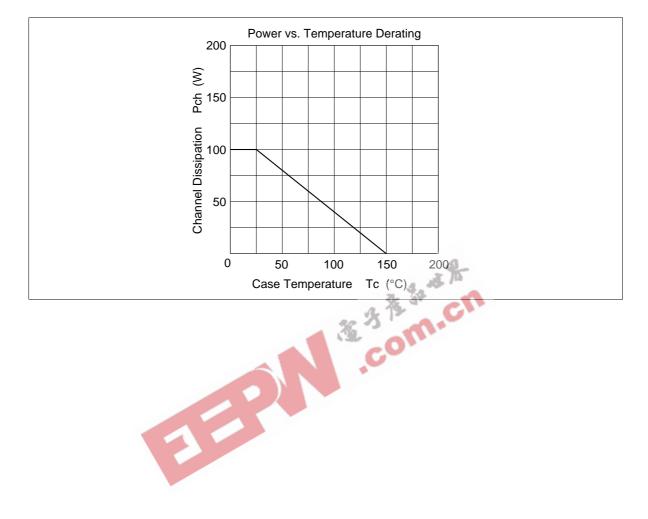


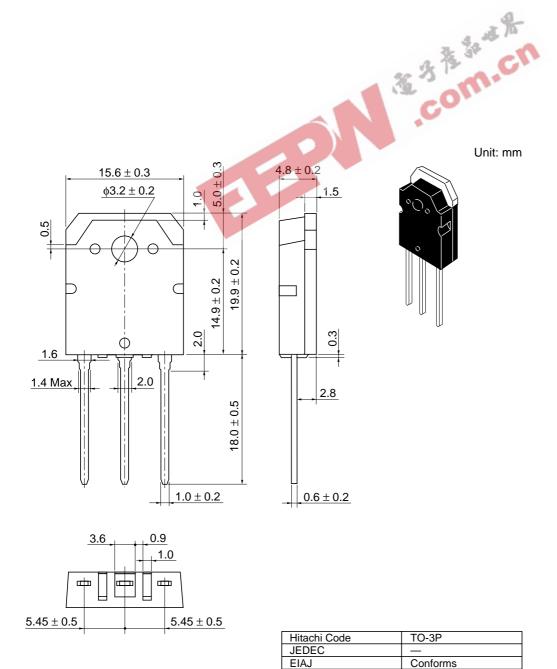
# **Electrical Characteristics** ( $Ta = 25^{\circ}C$ )

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	500	_	_	V	$I_D = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±30	_	_	V	$I_{G} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±10	μΑ	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	250	μΑ	$V_{DS} = 400 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	2.0	_	3.0	V	$I_D = 1 \text{ mA}, V_{DS} = 10 \text{ V}$
Static drain to source on state resistance	R <sub>DS(on)</sub>	_	0.5	0.6	Ω	$I_D = 6 \text{ A}$ $V_{GS} = 10 \text{ V}^{*1}$
Forward transfer admittance	y <sub>fs</sub>	6.0	10	_	S	$I_{D} = 6 \text{ A}$ $V_{DS} = 10 \text{ V}^{*1}$
Input capacitance	Ciss	_	1560	_	pF	V <sub>DS</sub> = 10 V
Output capacitance	Coss	_	450	- 為	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	72	2	pF	f = 1 MHz
Turn-on delay time	t <sub>d(on)</sub>	-	22	7:0	ns	I <sub>D</sub> = 6 A
Rise time	t <sub>r</sub>	$\overline{A}$	78	1	ns	V <sub>GS</sub> = 10 V
Turn-off delay time	t <sub>d(off)</sub>	<del>-)</del> \	140		ns	$R_L = 5 \Omega$
Fall time	t <sub>i</sub>		60	_	ns	
Body to drain diode forward voltage	V <sub>DF</sub>		1.1	_	V	$I_F = 12 \text{ A}, V_{GS} = 0$
Body to drain diode reverse recovery time	t <sub>rr</sub>	_	105	_	ns	$I_F = 12 \text{ A}, V_{GS} = 0$ diF / dt = 100 A / $\mu s$

Note: 1. Pulse Test

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EIAJ

Weight (reference value)

5.0 g

#### **Cautions**

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